

#### 650V N-Channel MOSFET

#### **General Features**

- Proprietary New Planar Technology
- R<sub>DS(ON),typ</sub>=0.38 Ω@V<sub>GS</sub>=10V
- Low Gate Charge Minimize Switching Loss
- Fast Recovery Body Diode

### **Applications**

- > Adaptor
- > TV Main Power
- SMPS Power Supply
- LCD Panel Power

# Ordering Information

Part Number	Package	Brand						
PTP20N65A	TO-220	ž						
PTA20N65A	TO-220F	ï						

## **Absolute Maximum Ratings**

Symbol	Parameter	PTP20N65A	PTA20N65A	Unit	
V <sub>DSS</sub>	Drain-to-Source Voltage <sup>[1]</sup>	65	V		
V <sub>GSS</sub>	Gate-to-Source Voltage	±	±30		
I <sub>D</sub>	Continuous Drain Current	2	0		
<b>I</b> <sub>D @ Tc =100</sub> ℃	Continuous Drain Current @ Tc=100℃	Figu	А		
I <sub>DM</sub>	Pulsed Drain Current at V <sub>GS</sub> =10V <sup>[2]</sup>	Figure 6			
E <sub>AS</sub>	Single Pulse Avalanche Energy	1200		mJ	
dv/dt	Peak Diode Recovery dv/dt <sup>[3]</sup>	5.0		V/ns	
D	Power Dissipation	160	65	W	
P <sub>D</sub>	Derating Factor above 25°C	1.28	0.52	W/°C	
T <sub>L</sub> T <sub>PAK</sub>	Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10 seconds, Package Body for 10 seconds	300 260		°C	
T <sub>J</sub> & T <sub>STG</sub>	Operating and Storage Temperature Range	-55 to 150			

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

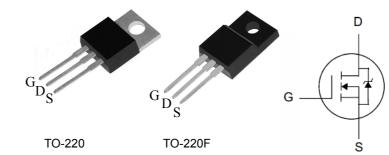
#### **Thermal Characteristics**

Symbol	Parameter	PTP20N65A	PTA20N65A	Unit
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction-to-Case	0.78	1.92	
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction-to-Ambient	62	100	°C <b>/W</b>

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### ▶ Lead Free Package and Finish

BV <sub>DSS</sub>	R <sub>DS(ON),typ.</sub>	I <sub>D</sub>
650V	0.38Ω	20A



Package No to Scale

 $T_C {=} 25 \, {}^\circ \! \mathrm{C}$  unless otherwise specified

# **Electrical Characteristics**

#### **OFF Characteristics** $T_J = 25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
BV <sub>DSS</sub>	Drain-to-Source Breakdown Voltage	650			V	$V_{GS}$ =0V, I <sub>D</sub> =250uA
	Drein to Courses Lookage Current			1	uA	V <sub>DS</sub> =650V, V <sub>GS</sub> =0V
I <sub>DSS</sub>	Drain-to-Source Leakage Current			100		V <sub>DS</sub> =520V, V <sub>GS</sub> =0V, T <sub>J</sub> =125℃
	Cate to Source Lookage Current			+100	~^	V <sub>GS</sub> =+30V, V <sub>DS</sub> =0V
I <sub>GSS</sub>	Gate-to-Source Leakage Current			-100	nA	V <sub>GS</sub> =-30V, V <sub>DS</sub> =0V

#### **ON** Characteristics

ON Characteristics				$T_J$ =25 °C unless otherwise specified		
Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
R <sub>DS(ON)</sub>	Static Drain-to-Source On-Resistance <sup>[4]</sup>		0.38	0.50	Ω	V <sub>GS</sub> =10V, I <sub>D</sub> =10A
V <sub>GS(TH)</sub>	Gate Threshold Voltage	2.0		4.0	V	$V_{DS}$ = $V_{GS}$ , $I_D$ =250uA
gfs	Forward Transconductance <sup>[4]</sup>		15		S	VDS=15V,ID=10A

#### **Dynamic Characteristics**

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
C <sub>iss</sub>	Input Capacitance		2600		pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1.0MH <sub>Z</sub>
C <sub>rss</sub>	Reverse Transfer Capacitance		36			
C <sub>oss</sub>	Output Capacitance		230			
Qg	Total Gate Charge		65			
Q <sub>gs</sub>	Gate-to-Source Charge		12		nC	$V_{DD}$ =325V, I <sub>D</sub> =20A, $V_{GS}$ =0 to 10V
$Q_{gd}$	Gate-to-Drain (Miller) Charge		25			

#### **Resistive Switching Characteristics**

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
td(ON)	Turn-on Delay Time		35			
trise	Rise Time		190			V <sub>DD</sub> =325V, I <sub>D</sub> =20A,
td(OFF)	Turn-Off Delay Time		75		nS	V <sub>GS</sub> = 10V Rg=25 Ω
tfall	Fall Time		130			



#### **Source-Drain Body Diode Characteristics**

 $T_J {=} 25\,^\circ\!\mathrm{C}$  unless otherwise specified

Symbol	Parameter	Min	Тур.	Max.	Unit	Test Conditions
I <sub>SD</sub>	Continuous Source Current <sup>[4]</sup>			20	A	Integral PN-diode in MOSFET
I <sub>SM</sub>	Pulsed Source Current <sup>[4]</sup>			80		
V <sub>SD</sub>	Diode Forward Voltage			1.5	V	I <sub>S</sub> =20A, V <sub>GS</sub> =0V
trr	Reverse recovery time		800		ns	V <sub>GS</sub> =0V ,I <sub>F</sub> =20A,
Qrr	Reverse recovery charge		3.5		uC	di⊧/dt=100A/µs

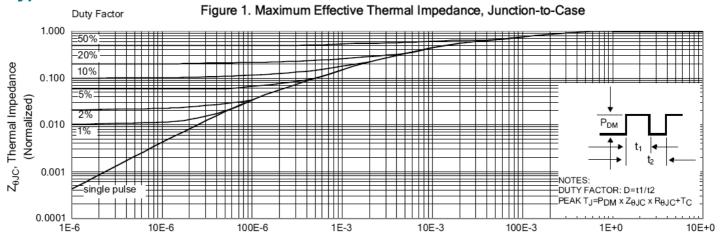
Note:

[1] T<sub>J</sub>=+25℃ to +150℃

- [2] Repetitive rating; pulse width limited by maximum junction temperature. [3] IsD= 20A di/dt < 100 A/ $\mu$ s, VDD < BVDss, TJ=+150 °C.
- [4] Pulse width≤380µs; duty cycle≤2%.

# PTP20N65A PTA20N65A

#### **Typical Characteristics**



t<sub>p</sub>, Rectangular Pulse Duration (s)

Figure 2. Maximum Power Dissipation vs Case Temperature

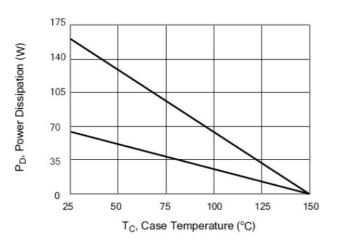


Figure 4. Typical Output Characteristics

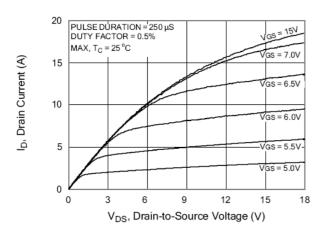


Figure 3. Maximum Continuous Drain Current vs Case Temperature

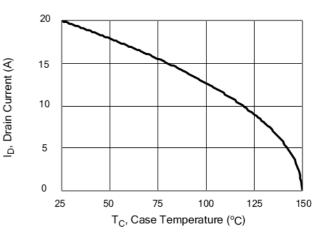
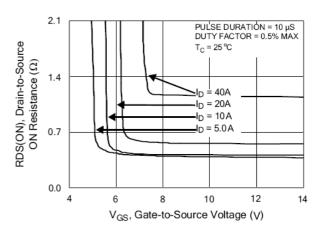
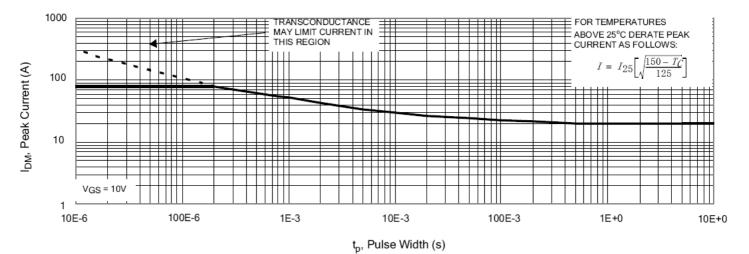


Figure 5. Typical Drain-to-Source ON Resistance vs Gate Voltage and Drain Current



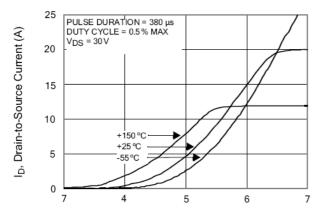
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# Typical Characteristics(Cont.)



#### Figure 6. Maximum Peak Current Capability

Figure 7. Typical Transfer Characteristics



V<sub>GS</sub>, Gate-to-Source Voltage (V)

Figure 9. Typical Drain-to-Source ON Resistance vs Drain Current

Figure 8. Unclamped Inductive Switching Capability

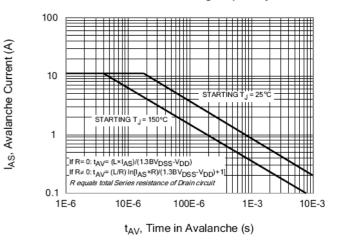
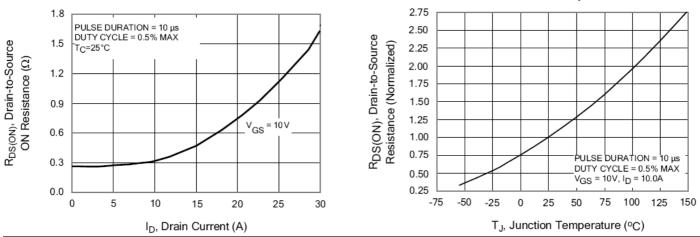


Figure 10. Typical Drain-to-Source ON Resistance vs Junction Temperature

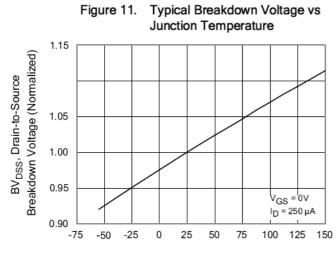


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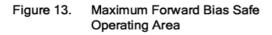
100

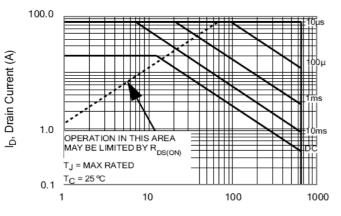
125 150

#### **Typical Characteristics**(Cont.)

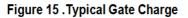


T<sub>J</sub>, Junction Temperature (°C)





V<sub>DS</sub>, Drain-to-Source Voltage (V)



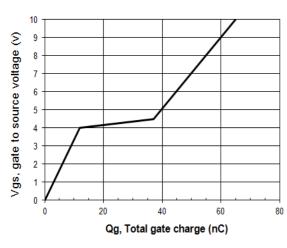


Figure 12. Typical Threshold Voltage vs Junction Temperature V<sub>GS(TH)</sub>, Threshold Voltage 1.1 1.0 (Normalized) 0.7 0.6 VDS VGS I<sub>D</sub> = 250 μA 0.5 -50 50 75



T<sub>J</sub>, Junction Temperature (°C)

25

-75

-25

0

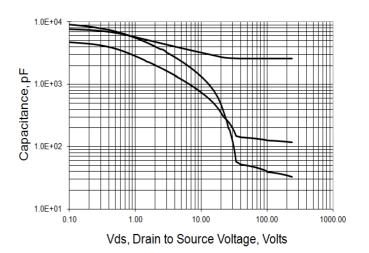
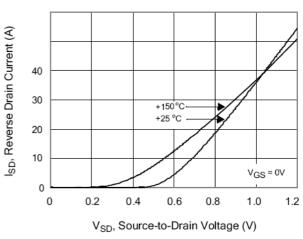
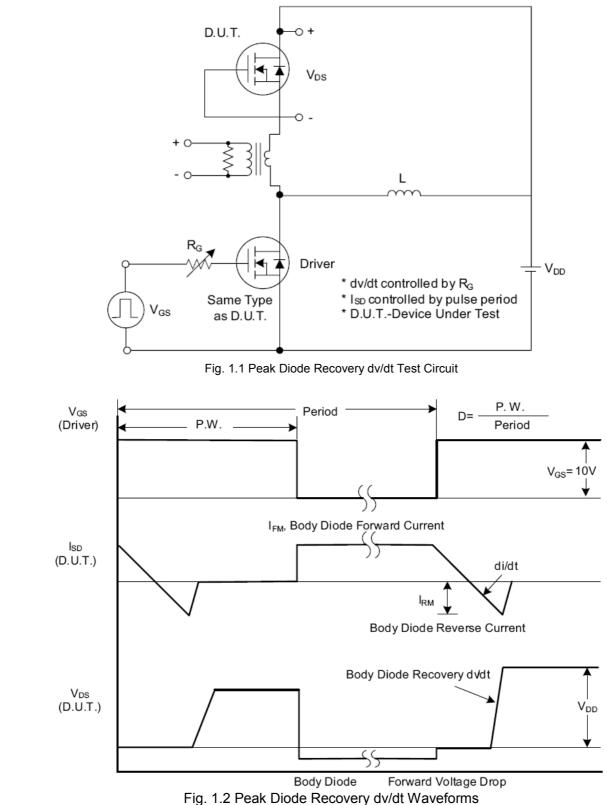


Figure 16. Typical Body Diode Transfer Characteristics



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# 2

# PTP20N65A PTA20N65A

# Test Circuits and Waveforms (Cont.)

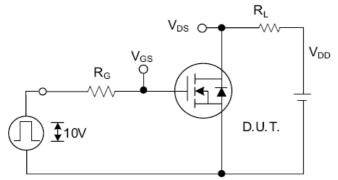


Fig. 2.1 Switching Test Circuit

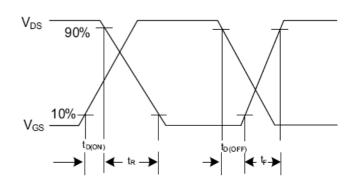


Fig. 2.2 Switching Waveforms

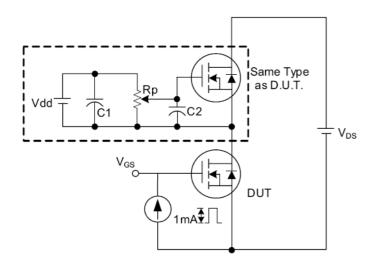


Fig. 3 . 1 Gate Charge Test Circuit

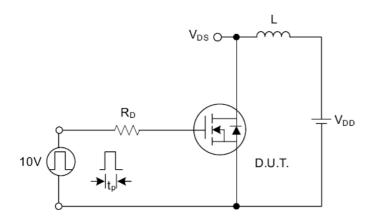


Fig. 4.1 Unclamped Inductive Switching Test Circuit

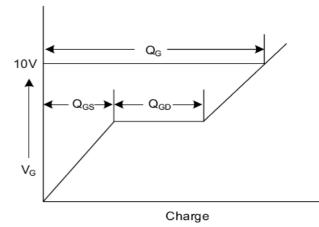
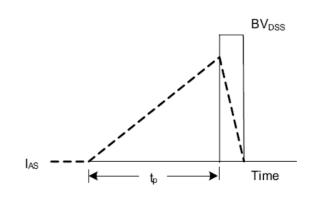
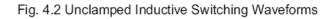


Fig. 3.2 Gate Charge Waveform





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